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Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/612,243	QIAN ET AL.	
Examiner	Art Unit	
John L. Goodrow	1756	

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Class	Subclass	Date	Examiner
430	109.31	8/16/2005	JG
	109.1		
	109.3		
	120		
	137.1		

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
430	109.31	8/16/2005		
	109.1;3			
430	120			
430/137.1				

SEARCH NOT (INCLUDING SEARCH	TES STRATEGY	)
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inventor name search	8/16/2005	JG
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